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	APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU		EXAMINER	
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	**APPLICANT	S: Nikami	Takashi;		ليسيا			
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	oreign priority claims		⊐ yes ⊡	⊒no ·	- American Control of the Control of	ATT	ORNEY DOCKET NO	
	35 USC 119 conditions met ☐ yes ☐ no Verified and Acknowledged Examiners's initials			020277				
	TITLE: Semiconductor device and method for fabricaling the same							
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	Amount Due	Date Paid		Sheets Drwg.	Figs.Drwg. Print Fig.			
,			Primary Examiner					
	TERMINAL		PREPARED FOR ISSUE	Application Examiner				
		DISCLAMER	WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.					
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